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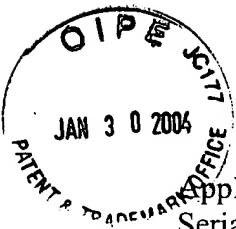
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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Shunpei Yamazaki et al.
Serial No. : 09/917,095
Filed : July 26, 2001
Title : PLASMA CVD METHOD

Art Unit : 2829
Examiner : Evan T. Pert
Confirmation No.: 2034

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

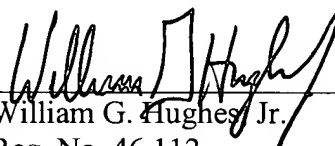
SECOND REQUEST FOR INITIALED PTO FORMS 892

Further to a request filed December 1, 2003 and upon reviewing the file, applicants noted that they have not received initialed copies of the enclosed PTO Forms 892 that accompanied the application filed July 26, 2001.

Applicants' records show that the submission of these documents complied with 37 CFR 1.97. Thus, it is respectfully requested that the examiner initial and return these forms as soon as possible. Note, applicants are paying the issue fee concurrently herewith, so the Examiner's prompt attention to this matter would be appreciated.

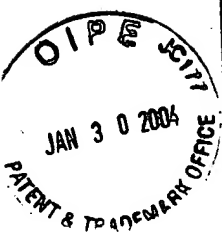
Respectfully submitted,

Date: January 30, 2004



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Notice of References Cited

Application/Control No.

09/457,128

Applicant(s)/Patent Under
Reexamination
YAMAZAKI ET AL.

Examiner

Art Unit

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
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	B	US-6103992-	08-2000	NODDIN	219	121.71
	C	US-6015762-	01-2000	YAMAZAKI et al	438	788
	D	US-5571578-	11-1996	KAJI et al	427	579
	E	US-5472825-	12-1995	SAYKA	430	311
	F	US-4917044-	04-1990	YAU et al	118	723
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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office
PTO-892 (Rev. 01-2001)

Notice of References Cited

Part of Paper No. 6

Alfred J. J. 4/2/01

Notice of References Cited

Application No.
08/748,233

Applicant(s)

Yamazaki et al

Examiner

Thanh Nguyen

Group Art Unit
2813

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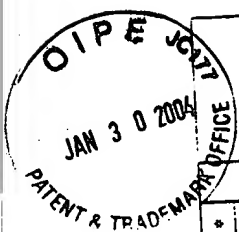
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B	4,917,044	4/17/90	Yau et al.	118	723
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Applicant(s)

Yamazaki et al

Examiner

Thanh Nguyen

Group Art Unit
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